## Application/Control No. Applicant(s)/Patent Under Reexamination 10/002.978 HSIEH ET AL. Notice of References Cited Examiner Art Unit Page 1 of 1 Thao X Le 2814 **U.S. PATENT DOCUMENTS** Document Number Date Classification Name Country Code-Number-Kind Code MM-YYYY US-6,163,050 12-2000 Hisatomi et al. 257/324 Α US-6,187,633 02-2001 438/261 В Dong et al. \* US-6,235,652 С 05-2001 Cook et al. 438/787 \* US-4,954,867 09-1990 Hosaka, Takashi 257/639 D Е US-5,286,994 02-1994 Ozawa et al. 257/411 US-6,469,343 10-2002 257/324 F Miura et al. US-G US-Н US-1 US-J US-Κ L US-US-М FOREIGN PATENT DOCUMENTS Document Number Date Country Name Classification Country Code-Number-Kind Code MM-YYYY Ν O Р Q R s Т **NON-PATENT DOCUMENTS** Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) U

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